

Inermal Characteristics									
Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient ^A	t ≤ 10s	Б	70	90	°C/W				
Maximum Junction-to-Ambient ^A	Steady-State	κ _{θJA}	100	125	°C/W				
Maximum Junction-to-Lead ^C	Steady-State	$R_{ ext{ heta}JL}$	63	80	°C/W				

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V
I _{DSS} Zero	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V				1	μA
			T _J =55°C			5	μΛ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±16V				10	uA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$		1	1.32	1.8	V
I _{D(ON)}	On state drain current	V _{GS} =10V, V _{DS} =5V		30			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =4.2A			43	52	mΩ
			T _J =125°C		58	74	
		V _{GS} =4.5V, I _D =2A			59	75	mΩ
g fs	Forward Transconductance	V _{DS} =5V, I _D =4.2A			8.5		S
V _{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.77	1	V
I _S	Maximum Body-Diode Continuous Curr	s Current				1.8	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			269	340	pF
C _{oss}	Output Capacitance				65		pF
C _{rss}	Reverse Transfer Capacitance				41		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			1	1.5	Ω
SWITCHI	NG PARAMETERS				-		
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =4.2A			5.7	7.2	nC
Q _g (4.5V)	Total Gate Charge				3		nC
Q _{gs}	Gate Source Charge				1.37		nC
Q_{gd}	Gate Drain Charge				0.65		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =15V, R _L =3.6Ω, R _{GEN} =3Ω			2.6	3.8	ns
t _r	Turn-On Rise Time				5.5	8	ns
t _{D(off)}	Turn-Off DelayTime				15.2	23	ns
t _f	Turn-Off Fall Time				3.7	5.5	ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =4.2A, dl/dt=100A/μs			15.5	21	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =4.2A, dI/dt=100A/μs			7.1		nC

A: The value of R $_{0.1A}$ is measured with the device mounted on 1 in ² FR-4 board with 2oz. Copper, in a still air environment with T $_{A}$ =25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\rm 0JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm 0JL}$ and lead to ambient.

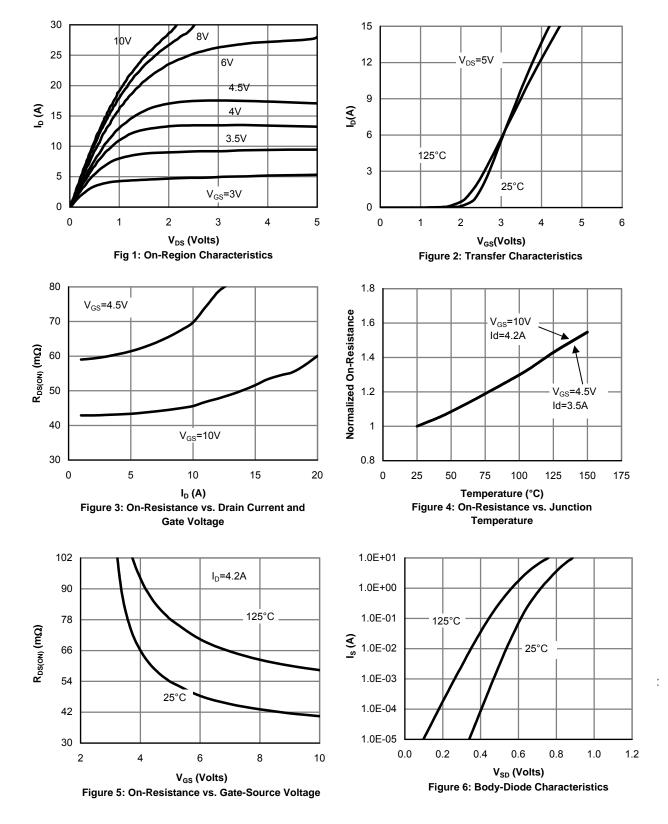
D. The static characteristics in Figures 1 to 6 are obtained using <300 $\,\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T _A=25°C. The SOA curve provides a single pulse rating.

F.The current rating is based on the t ${\leqslant}10s$ thermal resistance rating.

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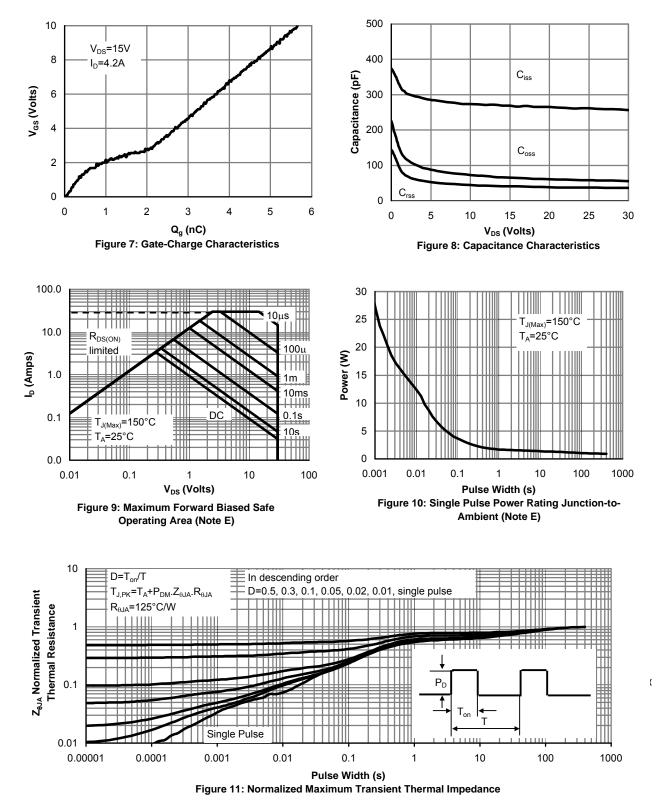
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